SHIGA7.045APC PATENT

## IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

OK TO ENTER: /JSC/

03/14/2008

**Applicant** 

Masuda et al.

Appl. No.

10/568,126

Filed

February 14, 2006

For

POSITIVE PHOTORESIST

COMPOSITION AND RESIST

PATTERN FORMATION

Examiner

Chu, John S Y.

Group Art Unit

1752

## **RESPONSE TO OFFICE ACTION**

Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

Dear Sir:

In response to the Office Action mailed **December 5, 2007**, please consider the following remarks:

**The listing of claims** begins on page 2 of this paper solely for the Examiner's convenience. No amendments have been made.

Remarks/Arguments begin on page 4 of this paper.